Two-Dimensional Lead at the Graphene/Silicon Carbide Interface

Alexander Vera$^{1,2}$, Wilson Yanez$^{2,3}$, Kaijie Yang$^{2,3}$, Boyang Zheng$^{2,3}$, Chengye Dong$^{4,5}$, Yuanxi Wang$^5$, Timothy Bowen$^{1,2}$, Hesham El-Sherif$^6$, Gopi Krishnan$^6$, Siavash Rajabpour$^{4,7}$, Maxwell Wetherington$^8$, Roland J. Koch$^9$, Eli Rotenburg$^9$, Nabil Bassim$^{6,10}$, Vincent Crespi$^{1,2,3,5,8,11}$, Chaoxing Liu$^{2,3}$, Nitin Samarth$^{2,3,5}$, Joshua A. Robinson$^{1,2,3,5,8,11,12}$*

1. Department of Materials Science and Engineering, The Pennsylvania State University, University Park, PA, USA
2. Center for Nanoscale Science, The Pennsylvania State University, University Park, PA, USA
3. Department of Physics, The Pennsylvania State University, University Park, PA, USA
4. Center for 2-Dimensional and Layered Materials, The Pennsylvania State University, University Park, PA, USA
5. 2-Dimensional Crystal Consortium, The Pennsylvania State University, University Park, PA, USA.
6. Department of Materials Science and Engineering, McMaster University, Hamilton, Ontario, Canada
7. Department of Chemical Engineering, The Pennsylvania State University, University Park, PA, USA
8. Materials Research Institute, The Pennsylvania State University, University Park, PA, USA
9. Advanced Light Source, Lawrence Berkeley National Laboratory, Berkeley, CA, USA
10. Canadian Centre for Electron Microscopy, McMaster University, Hamilton, Ontario, Canada
11. Department of Chemistry, The Pennsylvania State University, University Park, PA, USA.
12. Center for Atomically Thin Multifunctional Coatings, The Pennsylvania State University, University Park, PA, USA.

* jrobinson@psu.edu

Abstract

A stable platform to synthesize ultrathin heavy metals, with a strong interfacial Rashba effect, could lead to high efficiency charge-to-spin conversion for next-generation spintronics. Here we report wafer-scale synthesis of air-stable, epitaxially registered monolayer Pb on SiC (0001) via confinement heteroepitaxy (CHet). The stark asymmetric interfacial bonding in this heavy metal system lends to strong Rashba spin-orbit coupling near the Fermi level. Additionally, the system’s air stability enables ex-situ spin torque ferromagnetic resonance (ST-FMR) measurements that demonstrate charge-to-spin...
conversion in CHet-based 2D-Pb/ferromagnet heterostructures and a 1.5x increase in the effective field ratio compared to control samples.

Introduction

The field of spintronics utilizes the degree of freedom in spin to perform logic and store memory. One avenue of spintronic integration into current semiconductor technology is predicated on efficient charge-to-spin conversion in a current-induced spin polarization (CISP) layer underneath a ferromagnet, which depends on materials that exhibit strong spin-based phenomena, such as heavy metals\textsuperscript{1–3}. The interplay between intrinsic and interfacial Rashba spin-orbit coupling (SOC) in ultra-thin heavy metals\textsuperscript{4,5} could lead to anomalous spin phenomena compared to bulk heavy metals. Ultrathin Pb films exhibit large spin-orbit induced gaps\textsuperscript{6–8} and enhanced, Zeeman protected, type II superconductivity due to this coupling\textsuperscript{9,10}; however, studies are limited to \textit{in-situ} ultra-high vacuum characterization due to material sensitivity\textsuperscript{11}. Additional exploitation of these properties in spintronic device architectures is only possible if the Pb can be stabilized against environmental degradation during \textit{ex-situ} processing\textsuperscript{12–14}. Leveraging recent advances in epitaxial graphene intercalation,\textsuperscript{11,15,16} it becomes evident that stable 2D heavy metals with facile device integration are possible. This route, dubbed “confinement heteroepitaxy” (CHet)\textsuperscript{17}, leverages the high-energy interface between epitaxial graphene (EG) and silicon carbide (SiC) to assemble atomically thin 2D metals via elevated temperature intercalation under a near-atmospheric argon environment. CHet-based 2D metals exhibit single-crystal-like behavior with a unique asymmetric bonding environment, and robustness against degradation in the ambient,\textsuperscript{17,18} such bonding asymmetry leads to extraordinary non-linear susceptibility and multiple epsilon-near-zero modes\textsuperscript{18–21}, tuneability through large-range miscible alloying\textsuperscript{18}, and superconductivity\textsuperscript{17}.

Early experiments on heavy metal intercalation at the EG/SiC interface focused on graphene modulation\textsuperscript{15,22} or nanoscale structural characterization\textsuperscript{16,23,24}. Here, we investigate the synthesis and characterization of CHet based 2D-Pb, explore its application as a CISP base layer in spintronic devices, and develop a theoretical understanding of spin transport in heavy metals made through CHet. We report uniform, large area (up to 1 cm\textsuperscript{2}) 2D-Pb with minimal oxidation, a \textasciitilde 500meV spin orbit induced gap at the Fermi level, evidence of enhanced charge to spin conversion, and calculated spin polarization values as a function of Fermi energy. In doing so, this
work establishes CHet-based 2D-Pb as a promising material platform for \textit{ex-situ} spin transport phenomena.

\textbf{Results and Discussion}

Synthesis of monolayer 2D-Pb on SiC is achieved via confinement heteroepitaxy (CHet), where bulk 3D lead is stabilized into its 2D crystalline allotrope via thermal evaporation and subsequent intercalation into a defect-engineered EG/SiC interface at 935°C for 2 hours. X-ray photoelectron spectroscopy (XPS) elucidates the evolution of bonding and chemistry at the interface throughout this process. Similar to previous reports, utilization of an O$_2$ plasma to generate defects leads to an XPS C1s spectra consisting of C=O, C-OH, and C-O-C bonding (between 286 – 288 eV), which are eliminated during the intercalation process (Figure 1a). In addition, peaks associated with the buffer layer (BL, between 285 – 286 eV) become undetectable, and the peak associated with SiC shifts to lower energy, while the Pb4f spectra (Figure 1b) exhibits strong metallic Pb4f peaks, suggesting replacement of the high energy buffer layer with metallic Pb atoms and healing of the defective graphene layer. Lateral coverage and surface morphology can be confirmed through scanning electron microscopy (SEM) (Figure 1c,d) and low-frequency Raman spectroscopy (Figure 1e,f). Initial evidence of Pb intercalation is achievable via backscattered electron imaging in SEM (Figure 1d). Electrons are deflected more readily for compositions with larger nuclei (i.e. larger atomic number Z) and thus these materials appear brighter in backscattered electron microscopy. We leverage the larger Z contrast expected in regions covered with heavy Pb atoms to visually differentiate these regions from unintercalated regions in SEM$^{25}$. High-Z contrast and Raman mapping (Figure 1d) demonstrate up to 93% coverage of 2D-Pb (Figure S1), with characteristic peaks of 2D-Pb found at 29, 52, and 89 cm$^{-1}$ (Figure 1d).$^{20}$
Due to the thermodynamic and chemical potential equilibrium, CHet-based 2D metals are predicted to generally be 1-3 atomic layers thick\textsuperscript{17,18,26}. First-principles calculations predict the equilibrium phase stability (Figure 1g,h) to marginally be a full layer, as shown in a tiny Pb chemical potential window where the free energy of full monolayer intercalation is lower than the case of no intercalation (0.0 eV) before Pb crystallization, and annular dark field scanning tunneling electron spectroscopy (ADF-STEM) and electron energy loss spectroscopy (EELS) with energy-dispersive X-ray spectroscopy (EDX) (Figure 1i) confirm that 2D-Pb is predominantly monolayer and epitaxial to SiC (Figure S2). Providing evidence that Pb marginally intercalates, a small change of the chemical environment will stop the intercalation process – which may explain increased intercalation temperatures and times as compared to smaller p-block intercalants\textsuperscript{17}.
Angle resolved photoemission spectroscopy (ARPES) in correlation with density functional theory (DFT) highlights the spin character of this 2D metal. In the momentum-resolved $\Gamma$ to $K_{\text{gra}}$ cut (Figure 2a,b) the dispersion associated with Pb on SiC splits starting half the way from $\Gamma$ to $M_{\text{Pb}}$ and $\Gamma$ to $K_{\text{Pb}}$. The same splitting is reflected in the DFT calculated band structure (Figure 2c,d) with SOC, suggesting broken spin degeneracy with a spin splitting of $\sim$500 meV near the Fermi level. Additionally, we noticed there are two bands "truncated," i.e. lose signal as they pass the avoided crossing in the experimental data (Figure 2d). To understand the origin of this truncation, we performed an ARPES simulation of monolayer Pb on top of SiC, graphene layer excluded in the model for computational simplicity (Figure 2f). The white lines in Figure 2f show the absent bands when considering ARPES matrix elements, while the color-shaded regions show the simulated ARPES results, which show a close correspondence to experiment. By comparing to the orbital-projected band structure (Figure S3), we see that ARPES picks up only initial states with

FIG 2: Electronic band structure of 2D-Pb/SiC. a) Measured ARPES of Gr/Pb/SiC along a path crossing high symmetry points b) $K_{\text{Pb}}$-$\Gamma$-$M_{\text{Pb}}$-$K_{\text{gra}}$. Bands originating from Pb-SiC are in dashed red boxes. c) Measured Fermi surface of Gr/Pb/SiC. d) Measured ARPES map from (a) overlaid with calculated band structure of Pb-SiC for the $\Gamma$ – $K_{\text{Pb}}$ cut and e) $\Gamma$ – $K_{\text{gra}}$ cut, showing strong agreement apart from “truncated” bands between $\Gamma$ and $M_{\text{Pb}}$. f) Simulated ARPES for monolayer Pb from $\Gamma$ to M. The k-path is extended slightly to ease comparison with experiment. Dashed white lines show where various bands lose their ARPES signal. The tight-binding model includes Pb p-orbitals and the pz orbital of the first layer of Si.
$p_z$ character, while the "missing" bands carry mainly $p_x/p_y$ character (Figure S3). This effect is robust under changes of incident light angle, photon energy and light polarization, suggesting a strong role for matrix element effects in the relative intensity of the different ARPES bands.

Room temperature spin torque ferromagnetic resonance (ST-FMR) measurements provide insight into spin transport phenomena in CHet-grown 2D-Pb. Using 50 µm x 10 µm soft ferromagnet permalloy/epitaxial graphene/2D-Pb heterostructure devices (Py/EG/Pb), an external magnetic field (H) to orient the magnetization of the ferromagnet is applied in combination with a radiofrequency (RF) current to generate a spin current in the graphene/Pb layer - causing a spin accumulation at the graphene/Py interface (Figure 3a). This creates a torque over the magnetization, causing it to precess and produce changes in the resistance of the ferromagnet due to anisotropic magnetoresistance. Thus, the magnetization dynamics of Py can be measured as a rectified DC voltage ($V_{mix}$) produced by the mixing of the applied RF current and the varying resistance of the ferromagnet. The resonance phenomenon is characterized by analyzing the spectrum due to the mixing voltage while sweeping the external magnetic field (H) across the resonance at a fixed RF current (Figure 3c). The spectrum is finally fit with a symmetric and antisymmetric Lorentzian distribution, as shown in Figure 3d. This results in a ratio of in-plane ($\tau_{\|}$) and out-of-plane torque ($\tau_{\perp}$) (Eq. 1) that is proportional to the amplitude of the symmetric ($V_S$) and antisymmetric ($V_A$) Lorentzian distribution, and the ratio of the effective field in the in-plane ($H_{DL}$) and out-of-plane ($H_{FL}$) directions, since the torque is proportional to the magnetization ($m$) and the effective field ($H_{eff}$) generated in the heterostructure ($\vec{\tau} = \vec{m} \times \vec{H}_{eff}$):  

$$\frac{H_{DL}}{H_{OE} + H_{FI}} = \frac{\tau_{\|}}{\tau_{\perp}} = \sqrt{1 + \frac{4\pi M_{eff}}{H_{res}} \frac{V_S}{V_A}}$$  

Here, $H_{OE}$ is the magnetic field generated by the flow of electrical current in the heterostructure, $H_{res}$ is the resonance field, and $4\pi M_{eff}$ is the demagnetization field obtained from fitting $H_{res}$ with the Kittel ferromagnetic resonance equation. In the current setup it is not possible to precisely determine the magnitude of the effective field or torque due to the unknown impedance of the measured devices$^{27-32}$. 

$$1$$
To quantify the effect of the spin and charge currents in the ferromagnetic/EG/2D-Pb heterostructure, the ratio of effective fields in 2D-Pb is computed at different frequencies (Figure 3e) and compared its value with a H-intercalated graphene control sample. On average, \( \frac{H_{DL}}{H_{OE}+H_{FL}} = 1.62 \pm 0.09 \) in graphene/Pb while it was \( \frac{H_{DL}}{H_{OE}+H_{FL}} = 0.97 \pm 0.19 \) in the control sample. These values indicate 2D-Pb increases the effective field ratio, thus enhancing the charge to spin conversion in the heterostructure. The possible presence of both damping-like and field-like effective fields in 2D systems (such as the one produced by Rashba-like spin textures in 2D gases or in the surface states of a 3D topological insulator)\textsuperscript{32–35} makes it difficult to precisely estimate the spin torque efficiency of 2D Pb. We expect that in the future we can perform a systematic thickness dependence study that will allow us to separate these contributions.

FIG 3: (a) Schematic diagram of the ST-FMR measurement. (b) Optical microscopy image of a 50 µm x 10 µm device used for ST-FMR experiments. We include the axis of our experiment and the directions of the current (I) and magnetic field (H). (c) ST-FMR spectra of a Py (6nm)/Graphene/Pb heterostructure measured at room temperature using an RF signal of 20 dBm ranging from 4 to 7 GHz. (d) ST-FMR spectra of the same heterostructure measured at 4 GHz showing the fit to the experimental data and the contribution of the in plane and out of plane torques to the measured signal. (e) Normalized magnitude of the measured effective fields obtained from the fit of the data shown on (c) in graphene/Pb and its comparison with a graphene control sample without Pb. (f) Magnitude of the symmetric (V\(_S\)) and antisymmetric (V\(_A\)) components of the mixing voltage signal obtained by changing the angle (\(\phi\)) between the current and the magnetic field. These values have been fitted using \( V_{mix} = V_{S(A)} \cos(\phi) \sin(2\phi) \) as mentioned in the main text.
Finally, angle dependent ST-FMR, where the angle (φ) between the current and the external magnetic field is changed, reveals the amplitude of the symmetric (S) and antisymmetric (A) components of the resonance peak as a function of φ (Figure 3e). Similar to other heavy metals in the 3D regime, the magnitude of the symmetric and antisymmetric components follows the usual $V_m = V_S(A)\cos(\phi)\sin(2\phi)$ angle dependence$^{32,33,36,37}$. This indicates that the direction of the spin polarization is completely in plane and perpendicular to the direction of the electrical current. This direction of spin polarization induced by electric current originates from the $C_{3v}$ symmetry of the 2D-Pb film. Considering the response equation $S_i = \chi_{ij}E_j$, where $S_i$ is the i-th component of spin density and $E_j$ is the electrical field in the j direction ($i = x, y, z$ and $j = x, y$). Symmetry analysis based on Neumann’s principle$^{38}$ suggests $\chi_{yx}$ as the only non-zero component (See Methods), which is indeed the component observed in experiments. This conclusion is further validated using a direct calculation of the current-induced spin polarization based on the linear response theory for the realistic tight-binding model based on Wannier function from the DFT calculations (See Methods for details of our numerical formalism$^{39}$). The spin texture at the Fermi surface is depicted in Figure 4a, which is similar to the Rashba type of spin-split bands. The corresponding values of $\chi_{yx}$ and $\chi_{zx}$ are shown in Figure 4b as a function of Fermi energy $E_F$. We find zero $\chi_{zx}$, as required by $C_{3v}$ symmetry, and non-zero $\chi_{yx}$, which shows strong dependence on the Fermi energy.

**Conclusion**
The synthesis of air-stable, large area, crystalline 2D-Pb via CHet allows for *ex-situ* investigation of ultrathin heavy metal spin properties and the formation of heterostructures designed to exploit these properties. Here we have reported on CHet-based 2D Pb’s large spin splitting gap and 1.5x increase in the effective field ratio for ST-FMR. In conjunction with theoretical calculations on spin transport, we have identified this material system to be a potential efficient spin-to-charge conversion layer for spintronic devices, and CHet as a promising material platform for the synthesis of spintronic-ready ultrathin heavy metals.

**Author Contributions**

A.V. and J.A.R. conceived the idea, directed the research, and wrote the paper with significant input from S.R., W.Y., K.Y., B.Z., Y.W., N.S., C.L., and V.H.C. A.V. carried out the synthesis of 2D-Pb with help from C.D. and T.B. who synthesized the graphene. A.V. conducted XPS, Raman, SEM, and EBSM under the supervision of J.A.R. Raman analysis is conducted by A.V. with advice from M.W. STEM, EDX, and EELS characterization is performed by H.E-S. and G.K. under the supervision of N.B. B.Z. and Y.W. performed phase stability calculations and computed the theoretical and simulated band structures under the direction of V.H.C. R.K. performed ARPES measurements under the direction of E.R. ST-FMR measurements are done by W.Y. with supervision from N.S. K.Y. calculated the theoretical spin transport in 2D-Pb with supervision from C.L. All authors contributed to analyzing and discussing the data. All authors have approved the manuscript.

**Conflicts of Interest**

There are no conflicts to declare.

**Acknowledgements**

This work is supported by NSF award DMR2002651 and the Penn State MRSEC Center for Nanoscale Science via NSF award DMR2011839. Raman, SEM, and XPS measurements were performed in the Materials Characterization Laboratory in the Materials Research Institute at Penn State University. Electron microscopy was performed at the Canadian Centre for Electron Microscopy, a Canada Foundation for Innovation Major Science Initiatives funded facility (also supported by NSERC and other government agencies). EM work was funded by the US AFOSR.
Award FA9550-19-1-0239 and the NSERC (Natural Sciences and Engineering Research Council of Canada) Discovery Grant program. A. Vera is supported by the Alfred P. Sloan Foundation G-2019-11435. T. Bowen is supported by an NSF Graduate Research Fellowship (ID 2019287067). B. Zheng and Y. Wang are supported by 2DCC-MIP under NSF cooperative agreement DMR-1539916 and DMR-2039351. We thank Y. Ou and J. Zhu for helpful discussions and A. Sengupta for providing access to the apparatus used in ST-FMR measurements.
References


Supplementary Information

Two-Dimensional Lead at the Graphene/Silicon Carbide Interface

Alexander Vera\textsuperscript{1,2}, Wilson Yanez\textsuperscript{2,3}, Kaijie Yang\textsuperscript{2,3}, Boyang Zheng\textsuperscript{2,3}, Chengye Dong\textsuperscript{4,5}, Yuanxi Wang\textsuperscript{5}, Timothy Bowen\textsuperscript{1,2}, Hesham El-Sherif\textsuperscript{6}, Gopi Krishnan\textsuperscript{6}, Siavash Rajabpour\textsuperscript{5,7}, Maxwell Wetherington\textsuperscript{8}, Roland J. Koch\textsuperscript{9}, Eli Rotenburg\textsuperscript{9}, Nabil Bassim\textsuperscript{6,10}, Vincent Crespi\textsuperscript{1,2,3,5,8,11}, Chaoxing Liu\textsuperscript{2,3}, Nitin Samarth\textsuperscript{2,3,5}, Joshua A. Robinson\textsuperscript{1,2,3,5,8,11,12*}

1. Department of Materials Science and Engineering, The Pennsylvania State University, University Park, PA, USA
2. Center for Nanoscale Science, The Pennsylvania State University, University Park, PA, USA
3. Department of Physics, The Pennsylvania State University, University Park, PA, USA
4. Center for 2-Dimensional and Layered Materials, The Pennsylvania State University, University Park, PA, USA
5. 2-Dimensional Crystal Consortium, The Pennsylvania State University, University Park, PA, USA.
6. Department of Materials Science and Engineering, McMaster University, Hamilton, Ontario, Canada
7. Department of Chemical Engineering, The Pennsylvania State University, University Park, PA, USA
8. Materials Research Institute, The Pennsylvania State University, University Park, PA, USA
9. Advanced Light Source, Lawrence Berkeley National Laboratory, Berkeley, CA, USA
10. Canadian Centre for Electron Microscopy, McMaster University, Hamilton, Ontario, Canada
11. Department of Chemistry, The Pennsylvania State University, University Park, PA, USA.
12. Center for Atomically Thin Multifunctional Coatings, The Pennsylvania State University, University Park, PA, USA

* jrobinson@psu.edu
Correlative X-ray photoelectron spectroscopy (XPS) and electron backscatter microscopy (EBSM) are used to illuminate the effect of parameter choice, such as temperature, on intercalation efficacy for 2D-Pb as opposed to other p-block intercalants. Individual samples are heated to 820°C - 910°C in 30°C increments and 910°C - 940°C in 15°C increments, all for 2 hours. Average atomic percent concentration of Pb increases from 820°C to 925°C then sharply decreases for 940°C, which strongly correlates to percent coverage from EBSM. This trend matches well with previous reports on intercalation with improvements for increasing temperature up until a thermodynamic preference for de-intercalation. Increased optimal intercalation temperatures for 2D-Pb as compared to 2D-Ga may be due to a smaller intercalation window in 2D-Pb’s phase stability plot, as seen in Figure 1g. EBSM thus can serve as a high-resolution micron-scale imaging technique for heavy 2D CHet metals.

FIG S1: Synthesis of 2D-Pb on SiC. a) High resolution C1s spectra from XPS for synthesis temperatures from 820°C to 940°C, b) high resolution Pb4f spectra overlaid from 820°C to 940°C, and c) a plot of estimated atomic percentages of Pb from XPS versus synthesis temperature, indicating a maximum near 925°C. Increased optimal intercalation temperatures for 2D-Pb as compared to 2D-Ga may be due to a smaller intercalation window in 2D-Pb’s phase stability plot, as seen in Figure 1g. d) Electron backscatter microscopy (EBSM) images for coverage percentages from 10% to 93% and e) atomic percentage of Pb (of entire composition including Si, C, O) from XPS vs. coverage percentages from EBSM, showing a strong linear correlation (r = 0.99971). EBSM thus can serve as a high-resolution micron-scale imaging technique for heavy 2D CHet metals.
Cross-sectional transmission electron microscopy (TEM) reveals that 2D-Pb is primarily monolayer, with lateral registry to silicon carbide (SiC) similar to that of 2D-Ga on SiC\textsuperscript{2} (Figure S2) which matches calculation\textsuperscript{4}.
A breakdown of orbital contributions to the band structure reveals a dominance of the Pb 6px and 6py orbitals in bands which appear absent from ARPES. This band disappearance thus may be because the matrix only has non-zero transition amplitudes for elements with initial states of pz character.

**FIG S3: Pb orbital contributions.** Computational description of the contributions from Pb-s, px, py, and pz orbitals. A vertical band between the Γ and M points has mostly px and py character, which may not show in experimental ARPES due to orbital selection rules.
### Methods

**Synthesis of 2D-Pb.** Atomically thin 2D-Pb is grown via confinement heteroepitaxy (CHet)² For this work, silicon carbide (II-VI Inc.) is diced into 1 x 0.5 cm substrates and pre-cleaned via a 20-minute soak in Nano-Strip (VWR, 90% sulfuric acid, 5% peroxymonosulfuric acid, <1% hydrogen peroxide). Subsequently, sublimation of silicon from the silicon carbide substrate is performed for 10 minutes at 1800°C in a 700 Torr argon atmosphere, yielding partially formed (50-90%) epitaxial graphene. Intercalation is achieved via heat treatment in a horizontal quartz tube (22 mm x 25 mm, inner x outer diameter) vacuum furnace, where lead powder (Sigma Aldrich, 99.999% trace metals basis, ~500 mg) is placed in an alumina crucible directly below a downward facing EG/SiC substrate. Prior to heating, the tube furnace is evacuated and backfilled with UHP forming gas (97% Ar, 3% H₂). Finally, the sample and Pb powder is heated to 800°C-935°C for 120 minutes

### TABLE S1: XPS peak positions.** Peak positions and full width half maxima (FWHM) for spectra from FIG S1. Spectra are charge corrected such that sp² sits at 284.5eV. An asymmetric Lorenzian lineshape is used to fit the sp² peak, while a symmetric Lorenzian is used to fit the carbide peaks. A U2 Tougaard background is used.

<table>
<thead>
<tr>
<th>Sample</th>
<th>Name</th>
<th>Position</th>
<th>FWHM</th>
</tr>
</thead>
<tbody>
<tr>
<td>2DPb_940C</td>
<td>Carbide (Pb-SiC)</td>
<td>282.59</td>
<td>0.76</td>
</tr>
<tr>
<td></td>
<td>sp²</td>
<td>284.5</td>
<td>0.73</td>
</tr>
<tr>
<td></td>
<td>Carbide (SiC)</td>
<td>283.01</td>
<td>0.76</td>
</tr>
<tr>
<td>2DPb_925C</td>
<td>Carbide (Pb-SiC)</td>
<td>282.34</td>
<td>0.74</td>
</tr>
<tr>
<td></td>
<td>sp²</td>
<td>284.5</td>
<td>0.68</td>
</tr>
<tr>
<td></td>
<td>Carbide (SiC)</td>
<td>283.06</td>
<td>0.74</td>
</tr>
<tr>
<td>2DPb_910C</td>
<td>Carbide (Pb-SiC)</td>
<td>282.45</td>
<td>0.83</td>
</tr>
<tr>
<td></td>
<td>sp²</td>
<td>284.5</td>
<td>0.72</td>
</tr>
<tr>
<td></td>
<td>Carbide (SiC)</td>
<td>283.06</td>
<td>0.79</td>
</tr>
<tr>
<td>2DPb_880C</td>
<td>Carbide (Pb-SiC)</td>
<td>282.42</td>
<td>0.79</td>
</tr>
<tr>
<td></td>
<td>sp²</td>
<td>284.5</td>
<td>0.71</td>
</tr>
<tr>
<td></td>
<td>Carbide (SiC)</td>
<td>283.09</td>
<td>0.79</td>
</tr>
<tr>
<td>2DPb_850C</td>
<td>Carbide (Pb-SiC)</td>
<td>282.41</td>
<td>0.79</td>
</tr>
<tr>
<td></td>
<td>sp²</td>
<td>284.5</td>
<td>0.69</td>
</tr>
<tr>
<td></td>
<td>Carbide (SiC)</td>
<td>283.04</td>
<td>0.79</td>
</tr>
<tr>
<td>2DPb_820C</td>
<td>Carbide (Pb-SiC)</td>
<td>282.72</td>
<td>0.7</td>
</tr>
<tr>
<td></td>
<td>sp²</td>
<td>284.5</td>
<td>0.72</td>
</tr>
<tr>
<td></td>
<td>Carbide (bulk)</td>
<td>283.12</td>
<td>0.7</td>
</tr>
</tbody>
</table>
under a forming gas (3% H₂) environment at 500 – 700 Torr, with 200 sccm total gas flow. The sample is then cooled to room temperature.

**X-ray Photoelectron Spectroscopy.** Samples are examined with a Physical Electronic Versa Probe II, using a monochromatic Al Kα X-ray source (hv = 1486.7 eV) with a radius of 100 µm and a concentric hemispheric analyzer. High resolution spectra are taken with a pass energy of 29.35 eV (Pb 4f and Si 2s) or 23.50 eV (C1s) and charge corrected for a graphene C1s spectra at 284.5 eV. A U 2 Tougaard background is used to fit the spectra.

**Raman Spectroscopy.** A Horiba LabRam Raman system is used to perform spectroscopy with a laser wavelength of 532nm at 4.1W. Double sweep spectra are taken with an accumulation time of 45 seconds and a grating of 600 grooves/mm.

**Scanning electron microscopy.** Samples are imaged using a Verios 5 XHR SEM in immersion mode, equipped with TLD (secondary electron) and MD (backscattered electron) detectors. Images are taken at either 5000x or 10000x resolution, with a beam current of 0.4 – 3.2nA and voltage of 2.00keV at working distances between 2 – 5.6mm.

**Scanning tunnelling electron microscopy analysis.** Cross-section from 2D Pb samples were prepared by a Helios G4 PFIB UXe DualBeam with a Xe⁺ plasma ion source. Electron beam at 5 keV and 6.4 nA was utilized to deposit a ~100 nm carbon protective coating. Then the Ga⁺ ion beam was used to deposit a 5 µm tungsten layer at 30 KeV. The samples were then prepared by performing a standard lift-out procedure and attached to a TEM half-grid. Finally, both sides of the samples were thinned in multiple steps by gradually lowering the ion beam voltage from 30 kV to 2 kV until the deposited tungsten is almost consumed, and the cross-section window appeared transparent in the electron beam image at 5 keV. The STEM images of the FIB cross-sections were performed in an FEI TITAN 80-300 KV HB Cubed Transmission Electron Microscope equipped with double corrector for both image and probe. HAADF images were done at 200 kV with a dose rate of less than 50 e/Å²/sec using an in-column Fischione HAADF detector (model 3000). The beam convergence angle was set to 19.1 mrad with a 50 µm C2 aperture and the collection angles of 63-200 mrad at 91 mm Camera length. The ADF STEM images were acquired at 300 kV and less than 50 pA screen current using Gatan ADF detector at 19.1 mrad with a 50 µm C2 aperture and the collection angles of 13-30 mrad at 91 mm Camera length. The elemental mapping of the interface (in Figure S2) was performed using core-loss EELS at 300
keV, 29.5 mm Camera Length at ~50 pA screen current using a direct electron detector Gatan K2 IS detector. EELS map was acquired at 0.0025 pixel time and 0.5 eV/channel electron dispersion, and 4 eV FWHM energy resolution. The EELS spectrum was denoised using Multi-statistical analysis (MSA) for performing the elemental mapping. The Hartree- Slater cross-section method was applied to extract the core-loss signals, and power-law fitting was applied to remove the background from the EELS signal. STEM-EDX analyses were performed in a Thermo Fisher Scientific Talos F200X analytical microscope at 200 kV, equipped with an X-FEG source and four in-column super-x silicon drift detectors (SDD). STEM-EDX spectrum image (SI) datasets were collected with a dwell time of 50 µs with an image size of 1024 x 1024 pixels. 50 pA of beam current was used at spot size 10 nm to avoid damage to the 2D Pb layer. The SI was collected, mapped, and analyzed using Velox software.

**Theoretical and simulated band structure.** The spin-orbit coupled first-principle calculations are performed with VASP\textsuperscript{5–7} at the PBE level\textsuperscript{8,9} with a wavefunction energy cutoff of 600 eV and a Γ-centered 13×13×1 k-point mesh. The tight-binding model hopping terms are extracted from the first-principle calculation with the code Wannier90\textsuperscript{10}. This tight-binding model is then used by the code chinook\textsuperscript{11} to simulate ARPES.

**Spin torque ferromagnetic resonance in 2D-Pb.** Six nanometers of permalloy (Ni\textsubscript{0.80}Fe\textsubscript{0.20}) were evaporated on top of CHet grown Pb. The films were later capped in situ with a 3 nm Al layer to prevent oxidation of the ferromagnetic layer, then subjected to standard lithography techniques, including etching with Ar and SF\textsubscript{6} to pattern the heterostructures into 50 um x 10 um devices which were then contacted using Ti/Au. The resistance of the devices was around 1Kohm. The ST-FMR spectra was measured from 3 GHz to 10 GHz in a probe station equipped with a 40A GSG RF picoprobe, a GMW 5201 projected field electromagnet, a Keysight E8257D analog signal generator and a Keithley 2182A nanovoltmeter. The angle dependent measurements were performed at 4 GHz in a different setup using a rotating stage, a GMW 3470 electromagnet, an Anritsu MG3692C signal generator and a Keithley 2182A nanovoltmeter.

**Symmetry analysis of \( \chi_{ij} \).** We apply symmetry operations \( \hat{T} \) on the response equation \( S_i = \chi_{ij}E_j \) where \( S_i \) is the spin polarization and \( E_j \) is the electrical field and the repeated indices means summation. Under the transformation, the spin polarization becomes \( \dot{S}_i = \det(T) T_{ij} S_j \), the electrical field is \( \dot{E}_i = T_{ij} E_j \) and \( \dot{S}_i = \chi'_{ij} \dot{E}_j \) where \( \det(T) \) is the determinant of \( T_{ij} \). There is a
The determinant for $S_i$ because $S_i$ is a pseudovector. Writing the transformed response equation in terms of the original quantities gives $\det(T) \ T_{ik} S_i = \chi'_{ij} T_{jk} E_k$, or equivalently, $S_i = \det(T) \ T_{ik}^{-1} \chi'_{ij} T_{jk} E_k$. Thus, the transformed response coefficient is determined by $\chi_{ik} = \det(T) \ T_{ik}^{-1} \chi'_{ij} T_{jk}$. For any symmetry of the system, we require $\chi'_{ij} = \chi_{ij}$ and the response coefficients need to satisfy

$$\chi_{ik} = \det(T) \ T_{ik}^{-1} \chi'_{ij} T_{jk}. $$

The current system has the $C_{3v}$ symmetry. The three-fold rotation $C_3$ about the z-axis can be given by the matrix

$$C_3 = \begin{pmatrix} \cos \frac{2\pi}{3} & -\sin \frac{2\pi}{3} & 0 \\ \sin \frac{2\pi}{3} & \cos \frac{2\pi}{3} & 0 \\ 0 & 0 & 1 \end{pmatrix}. $$

It gives $\chi_{xz}, \chi_{zy}, \chi_{zx}, \chi_{yz}$ to be zero, $\chi_{xx} = \chi_{yy}$ and $\chi_{xy} = -\chi_{yx}$. For the mirror symmetry, we choose the zx plane as the mirror plane, and the mirror symmetry operation $m_y$ is

$$m_y = \begin{pmatrix} 1 & 0 & 0 \\ 0 & -1 & 0 \\ 0 & 0 & 1 \end{pmatrix}. $$

Only the responses coefficients $\chi_{ij}$ with one of the indices as y are nonzero, namely, only $\chi_{xy}, \chi_{yx}, \chi_{yz}, \chi_{zy}$ are nonzero. Combing the requirements from these two symmetries, we have nonzero coefficients $\chi_{yx} = -\chi_{xy}$ for the current-induced spin polarization.

**Numerical method for the calculation of current-induced spin polarization.** We apply the linear response theory to calculate $\chi_{ij}$, which is given by

$$\chi_{ij} = -\frac{1}{2\pi} \int \frac{d^2k}{(2\pi)^2} \text{Tr} s_i G^R(\vec{k}, E_f) \Gamma_j(\vec{k}, E_f) G^A(\vec{k}, E_f).$$

The integral of momenta is over the Brillouin zone. $s_i$ is the spin operator. $G^R(G^A)$ is the retarded (advanced) Green’s function and given by

$$G^{R(A)}(\vec{k}, E) = \left( E - H(\vec{k}) - \Sigma^{R(A)}(E) \right)^{-1}. $$

The $H(\vec{k})$ is the tight binding Hamiltonian for 2D Pb on SiC and is constructed from the Wannier interpolation of the Density functional theory (DFT) with three p-orbitals of Pb atoms and one pz orbital of SiC. $\Sigma^{R(A)}(E)$ is the self-energies from the short range disorder and self-consistently given by
\[ \Sigma^R(E) = n_i V_0^2 \int \frac{d^2k'}{(2\pi)^2} G^R(\vec{k}', E). \]

\( n_i \) is the disorder density and \( V_0 \) is the disorder strength. We take \( n_i V_0^2 = 0.05 eV^2 \text{Å}^{-2} \) for the calculation. \( \Sigma^A(E) = (\Sigma^R(E))^\dagger \). \( \Gamma_j(\vec{k}, E) \) is the vertex correction taken in the ladder approximation and self-consistently given by:

\[ \Gamma_j(\vec{k}, E) = J_j(\vec{k}) + \gamma_j(E) \]

\[ \gamma_j(E) = n_i V_0^2 \int \frac{d^2k'}{(2\pi)^2} G^R(\vec{k}', E)(J_j(\vec{k}') + \gamma_j(E))G^A(\vec{k}', E). \]

where \( J_j(\vec{k}) = -e \partial_{\vec{k}_j} H(\vec{k}) \) is the current operator and \(-e\) is the electron charge.
References


